

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/735,886	TAKAYAMA ET AL.	
Examiner	Art Unit	
Nitin Parekh	2811	

SEARCHED					
Class	Subclass	Date	Examiner		
257	761-764 758,753	12/19/2005 (Updated)	NP		
	,				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East 2.0.1.4, USPTO, JPO, EPO, IBM Tech. Discl., Derwent	12/19/2005	NP		